

<b>Search Notes</b> 	<b>Application/Control No.</b>  10/736,381	<b>Applicant(s)/Patent under Reexamination</b>  DEMIR ET AL.
	<b>Examiner</b>  Edith M. Chang	<b>Art Unit</b>  2637

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner